SCHS231D – SEPTEMBER 1998 – REVISED DECEMBER 2002

- AC Types Feature 1.5-V to 5.5-V Operation and Balanced Noise Immunity at 30% of the Supply
- Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption
- Balanced Propagation Delays
- ±24-mA Output Drive Current
 Fanout to 15 F Devices
- SCR-Latchup-Resistant CMOS Process and Circuit Design
- Exceeds 2-kV ESD Protection Per MIL-STD-883, Method 3015

description/ordering information

The 'AC74 dual positive-edge-triggered devices are D-type flip-flops.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not related directly to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

T _A	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – E	Tube	CD74AC74E	CD74AC74E
–55°C to 125°C	SOIC – M	Tube	CD74AC74M	AC74M
		Tape and reel	CD74AC74M96	AC74W
	CDIP – F	Tube	CD54AC74F3A	CD54AC74F3A

ORDERING INFORMATION

⁺ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

_		(each fli	ip-flop)					
	INP	UTS		OUTPUTS				
PRE	CLR	CLK	D	Q	Q			
L	Н	Х	Х	Н	L			
н	L	Х	Х	L	Н			
L	L	Х	Х	H‡	н‡			
н	Н	\uparrow	Н	н	L			
н	н	\uparrow	L	L	Н			
н	Н	L	Х	Q ₀	\overline{Q}_0			

[‡] This configuration is nonstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



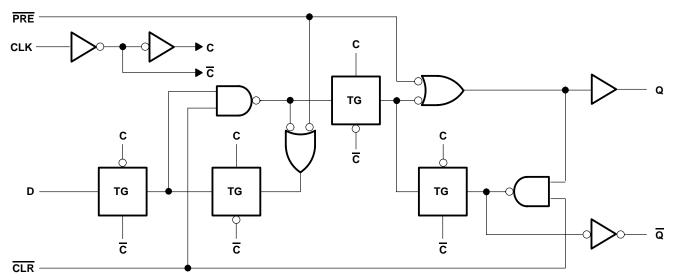
Copyright © 2002, Texas Instruments Incorporated On products compliant to MIL-PRF-3853s, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

CD54AC74F PACKAGE CD74AC74E OR M PACKAGE (TOP VIEW)									
1CLR 1D 1CLK 1PRE 1Q 1Q GD	2 3 4 5	Ο	12 11 10] V _{CC}] 2CLR] 2D] 2CLK] 2PRE] 2Q] 2Q					

1

SCHS231D - SEPTEMBER 1998 - REVISED DECEMBER 2002

logic diagram, each flip-flop (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 6 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC}) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 2): E package	80°C/W
M package	
Storage temperature range, T _{stg}	−65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



SCHS231D - SEPTEMBER 1998 - REVISED DECEMBER 2002

recommended operating conditions (see Note 3)

			T _A = 25°C		–55°C to 125°C		-40°C to 85°C		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX		
VCC	Supply voltage		1.5	5.5	1.5	5.5	1.5	5.5	V	
		V _{CC} = 1.5 V	1.2		1.2		1.2			
VIH	VIH High-level input voltage	$V_{CC} = 3 V$	2.1		2.1		2.1		V	
		V _{CC} = 5.5 V	3.85		3.85		3.85			
	Low-level input voltage	V _{CC} = 1.5 V		0.3		0.3		0.3		
VIL		$V_{CC} = 3 V$		0.9		0.9		0.9	V	
		V _{CC} = 5.5 V		1.65		1.65		1.65		
VI	Input voltage		0	VCC	0	VCC	0	VCC	V	
VO	Output voltage		0	VCC	0	VCC	0	VCC	V	
IOH	High-level output current	V _{CC} = 4.5 V to 5.5 V		-24		-24		-24	mA	
IOL	Low-level output current	V_{CC} = 4.5 V to 5.5 V		24		24		24	mA	
A+/A.v	Input transition rise or fall rate	V_{CC} = 1.5 V to 3 V		50		50		50		
Δt/Δv	Input transition rise or fall rate	V _{CC} = 3.6 V to 5.5 V		20		20		20	ns/V	

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CON	TEST CONDITIONS		T _A = 25°C		–55°C to 125°C		–40°C to 85°C		UNIT
			Vcc	MIN	MAX	MIN	MAX	MIN	MAX	
			1.5 V	1.4		1.4		1.4		
		I _{OH} = -50 μA	3 V	2.9		2.9		2.9		
	$V_I = V_{IH} \text{ or } V_{IL}$		4.5 V	4.4		4.4		4.4		
∨он		$I_{OH} = -4 \text{ mA}$	3 V	2.58		2.4		2.48		V
		I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8		
		$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V			3.85				
		I _{OH} = -75 mA†	5.5 V					3.85		
			1.5 V		0.1		0.1		0.1	
		I _{OL} = 50 μA	3 V		0.1		0.1		0.1	
			4.5 V		0.1		0.1		0.1	
VOL	VI = VIH or VIL	I _{OL} = 12 mA	3 V		0.36		0.5		0.44	V
		I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	
		$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V				1.65			
		I _{OL} = 75 mA [†]	5.5 V						1.65	
lj	$V_I = V_{CC}$ or GND		5.5 V		±0.1		±1		±1	μA
ICC	$V_I = V_{CC}$ or GND,	IO = 0	5.5 V		4		80		40	μA
Ci					10		10		10	pF

[†] Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.



SCHS231D – SEPTEMBER 1998 – REVISED DECEMBER 2002

timing requirements over recommended operating free-air temperature range, $V_{CC} = 1.5 V$ (unless otherwise noted)

				–55°C to 125°C		–40°C to 85°C		
				MAX	MIN	MAX		
fclock	Clock frequency			9		10	MHz	
•	Pulse duration	PRE or CLR low	50		44		ns	
t _w		CLK	56		49		115	
+	Cotum time	Data	44		39		ns	
t _{su}	Setup time	PRE or CLR inactive					ns	
t _h	Hold time	Data after CLK↑	0		0		ns	
trec	Recovery time, before CLK1	CLR↑ or PRE↑	34		30		ns	

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

				C to °C	–40°C to 85°C		UNIT
					MIN	MAX	
^f clock	Clock frequency			79		90	MHz
	Pulse duration	PRE or CLR low	5.6		4.9		ns
tw	uise duration	CLK	6.3		5.5		115
		Data	4.9		4.3		ns
t _{su}	Setup time	PRE or CLR inactive					ns
t _h	Hold time	Data after CLK↑	0		0		ns
t _{rec}	Recovery time, before CLK1	CLR↑ or PRE↑	4.7		4.1		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

				–55°C to 125°C		–40°C to 85°C	
	MIN	MAX	MIN	MAX			
fclock	Clock frequency			110		125	MHz
+	t _w Pulse duration	PRE or CLR low	4		3.5		ns
١w		CLK	4.5		3.9		115
+		Data	3.5		3.1		ns
t _{su}	Setup time	PRE or CLR inactive					ns
t _h	Hold time	Data after CLK↑	0		0		ns
t _{rec}	Recovery time, before CLK [↑]	CLR↑ or PRE↑	2.7		2.4		ns



SCHS231D - SEPTEMBER 1998 - REVISED DECEMBER 2002

switching characteristics over recommended operating free-air temperature range, $V_{CC} = 1.5 \text{ V}$, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	–55°C to 125°C		–40°C to 85°C		UNIT
		(6611 61)	MIN	MAX	MIN	MAX	
f _{max}			9		10		MHz
^t PLH		0		125		114	
^t PHL	CLK	Q or \overline{Q}		125		114	ns
^t PLH	PRE or CLR	0		132		120	200
^t PHL	PRE OF CLR	$Q \text{ or } \overline{Q}$		144		131	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	–55°C to 125°C		–40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
f _{max}			79		90		MHz
^t PLH		0	3.5	14	3.6	12.7	ns
^t PHL	CLK	Q or Q	3.5	14	3.6	12.7	115
^t PLH	PRE or CLR	0 == 0	3.7	14.7	3.8	13.4	ns
^t PHL	FRE UI CER	Q or Q	4	16.1	4.1	14.6	115

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

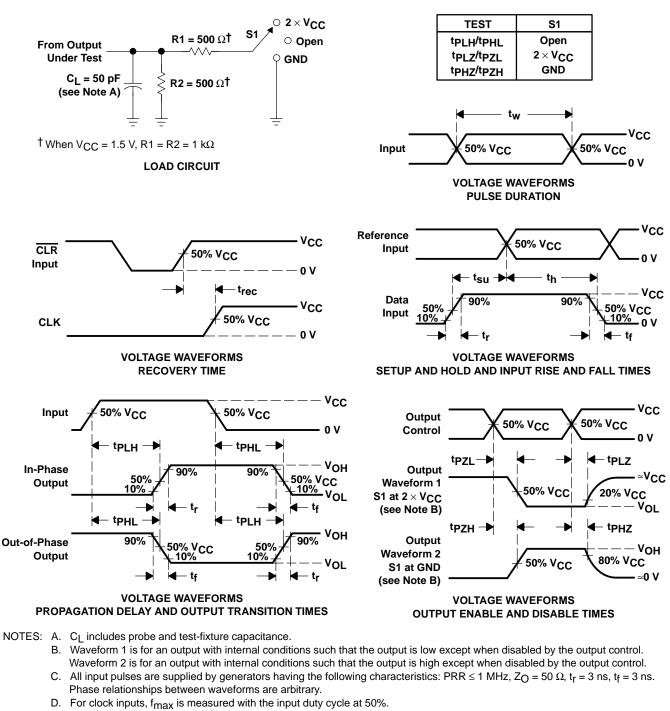
PARAMETER	FROM (INPUT)	TO (OUTPUT)	–55°(125		–40°(85°	UNIT	
			MIN	MAX	MIN	MAX	
f _{max}			110		125		MHz
^t PLH		0	2.5	10	2.6	9.1	ns
^t PHL	CLK	Q or Q	2.5	10	2.6	9.1	115
^t PLH	PRE or CLR	Q or Q	2.6	10.5	2.7	9.5	20
^t PHL	FRE OF CER	35	2.9	11.5	3	10.4	ns

operating characteristics, T_A = 25°C

PARAMETER			
Cpd	Power dissipation capacitance	55	pF

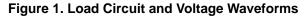


SCHS231D - SEPTEMBER 1998 - REVISED DECEMBER 2002



PARAMETER MEASUREMENT INFORMATION

- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpLH and tpHL are the same as tpd.
- G. tp71 and tp7H are the same as ten.
- H. tpLz and tpHz are the same as tdis.





PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD54AC74F3A	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type
CD74AC74E	ACTIVE	PDIP	Ν	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC74EE4	ACTIVE	PDIP	Ν	14	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC74M	ACTIVE	SOIC	D	14	50	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC74M96	ACTIVE	SOIC	D	14	2500	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC74M96E4	ACTIVE	SOIC	D	14	2500	Green (RoHS 8 no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC74ME4	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined. **Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered

at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



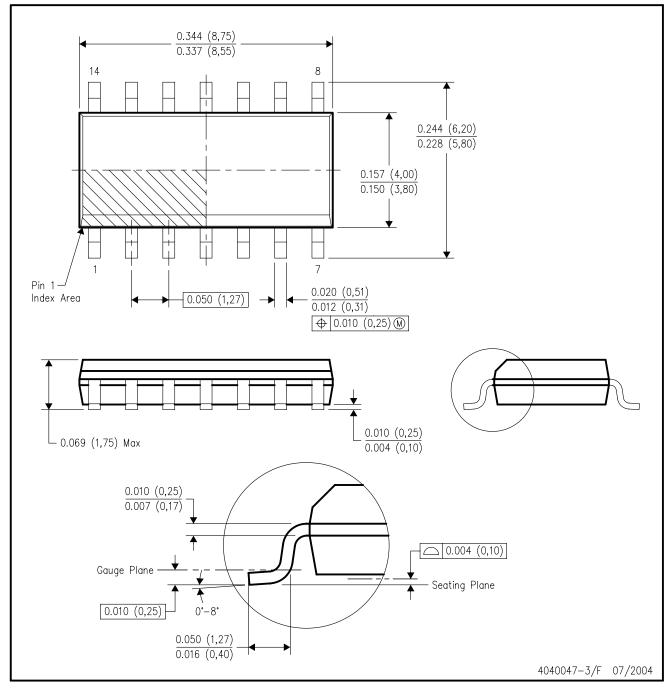
NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G14)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012 variation AB.



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